

Search Notes

Application/Control No.

10/812,972

Examiner

ERIC CHANG

Applicant(s)/Patent under
Reexamination

NIEN ET AL.

Art Unit

2116

SEARCHED

Class	Subclass	Date	Examiner
713	320	3/30/2008	EC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
713	320	3/30/2008	EC
PGPUB text search		3/30/2008	EC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST USPAT/PGPUB EPO/JPO	3/30/2008	EC
EAST keyword search in 713/320	3/30/2008	EC
Inventor name search		